

Search Notes

Application/Control No.

10/798,817

Examiner

Peter B. Kim

Applicant(s)/Patent under
Reexamination

MIURA, SEIYA

Art Unit

2851

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Searched (All databases) (See Printout)	9/5/2005	P/K